

Search Notes

Application/Control No.

10/801,177

Examiner

Y Quach Lee

Applicant(s)/Patent under
Reexamination

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Art Unit

2875

SEARCHED

Class	Subclass	Date	Examiner
362	184 187 188 202 203 232 238	2/22/2005	YMY
	240 250 285		
	286 288		
	800		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	2/22/2005	YMY